

Supporting Information

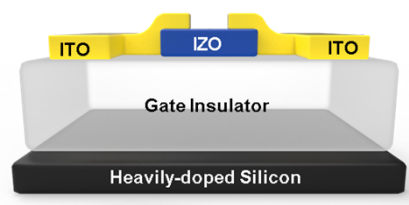
# Modification of a polymer gate insulator by zirconium oxide doping for low temperature, high performance indium zinc oxide transistors

*Byeong-Geun Son<sup>1</sup>, So Yeon Je<sup>1</sup>, Hyo Jin Kim<sup>1</sup> and Jae Kyeong Jeong<sup>1\*</sup>*

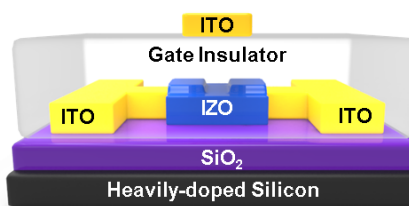
<sup>1</sup>Department of Materials Science and Engineering, Inha University, Incheon 402-751,

Republic of Korea

AUTHOR EMAIL ADDRESS: J. K. Jeong (jkjeong@inha.ac.kr)



(a)



(b)

**Figure S1.** Schematic cross-sections of the IZO TFTs with (a) bottom gate and (b) top gate structure.